

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10599944	BIENN ET AL.
	Examiner	Art Unit
	Michael Thier	2617

SEARCHED

Class	Subclass	Date	Examiner
	updated	1/19/2011	mtt

SEARCH NOTES

Search Notes	Date	Examiner
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INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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